

# BLF872

## UHF power LDMOS transistor

Rev. 01 — 20 February 2006

Product data sheet

## 1. Product profile

### 1.1 General description

A 300 W LDMOS RF power transistor for broadcast transmitter applications and industrial applications. The transistor can deliver 250 W broadband over the full UHF band from 470 MHz to 860 MHz. The excellent ruggedness and broadband performance of this device makes it ideal for digital transmitter applications.

#### CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Therefore care should be taken during transport and handling.

### 1.2 Features

- Typical 2-tone performance at 860 MHz, a drain-source voltage  $V_{DS}$  of 32 V and a quiescent drain current  $I_{DQ} = 2 \times 0.9$  A:
  - ◆ Peak envelope power load power  $P_{L(PEP)} = 300$  W
  - ◆ Gain  $G_p = 15$  dB
  - ◆ Drain efficiency  $\eta_D = 43$  %
  - ◆ Third order intermodulation distortion  $IMD3 = -28$  dBc
- Typical DVB performance at 858 MHz, a drain-source voltage  $V_{DS}$  of 32 V and a quiescent drain current  $I_{DQ} = 2 \times 0.9$  A:
  - ◆ Average output power  $P_{L(AV)} = 70$  W
  - ◆ Gain  $G_p = 15$  dB
  - ◆ Drain efficiency  $\eta_D = 30$  %
  - ◆ Third order intermodulation distortion  $IMD3 = -28$  dBc (4.3 MHz from center frequency)
- Advanced flange material for optimum thermal behavior and reliability
- Excellent ruggedness
- High power gain
- Designed for broadband operation (UHF band)
- Excellent reliability
- Internal input and output matching for high gain and optimum broadband operation
- Source on underside eliminates DC isolators, reducing common-mode inductance
- Easy power control

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### 1.3 Applications

- Communication transmitter applications in the UHF band
- Industrial applications in the UHF band

### 1.4 Quick reference data

**Table 1: Quick reference data**

Typical RF performance at  $V_{DS} = 32\text{ V}$  and  $T_h = 25\text{ °C}$  in a common-source narrowband 860 MHz test circuit. [1]

Mode of operation	f (MHz)	P <sub>L</sub> (W)	P <sub>L(PEP)</sub> (W)	P <sub>L(AV)</sub> (W)	G <sub>p</sub> (dB)	η <sub>D</sub> (%)	IMD3 (dBc)
CW, class AB	860	300	-	-	14	55	-
2-tone, class AB	f <sub>1</sub> = 860; f <sub>2</sub> = 860.1	-	300	-	15	42	-28
PAL BG	860 (ch69)	300 (peak sync.) [2]	-	-	15	42	-
DVB-T (8K OFDM)	858	-	-	70	15	30	-28 [3]

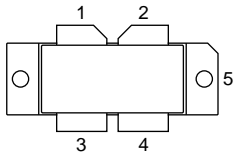
[1] T<sub>h</sub> is the heatsink temperature.

[2] Black video signal, sync expansion: input sync = 33 %; output sync ≥ 27 %.

[3] Measured dBc at 4.3 MHz from center frequency.

## 2. Pinning information

**Table 2: Pinning**

Description	Pin	Simplified outline
drain 1	1	
drain 2	2	
gate 1	3	
gate 2	4	
source	5	

[1] Connected to flange.

## 3. Ordering information

**Table 3: Ordering information**

Type number	Package		
	Name	Description	Version
BLF872	-	flanged LDMOST ceramic package; 2 mounting holes; 4 leads	SOT800-1

## 4. Limiting values

**Table 4: Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage		-	65	V
$V_{GS}$	gate-source voltage		-	$\pm 13$	V
$T_{stg}$	storage temperature		-65	+150	$^{\circ}\text{C}$
$T_j$	junction temperature		-	200	$^{\circ}\text{C}$

## 5. Thermal characteristics

**Table 5: Thermal characteristics**

Symbol	Parameter	Conditions	Typ	Unit
$R_{th(j-c)}$	thermal resistance from junction to case	$T_h = 25\text{ }^{\circ}\text{C}$	[1] 0.32	K/W
$R_{th(j-h)}$	thermal resistance from junction to heatsink	$T_h = 25\text{ }^{\circ}\text{C}$	[1][2] 0.4	K/W

[1]  $T_h$  is the heatsink temperature.

[2]  $R_{th(j-h)}$  is dependent on the applied thermal compound and clamping/mounting of the device.

## 6. Characteristics

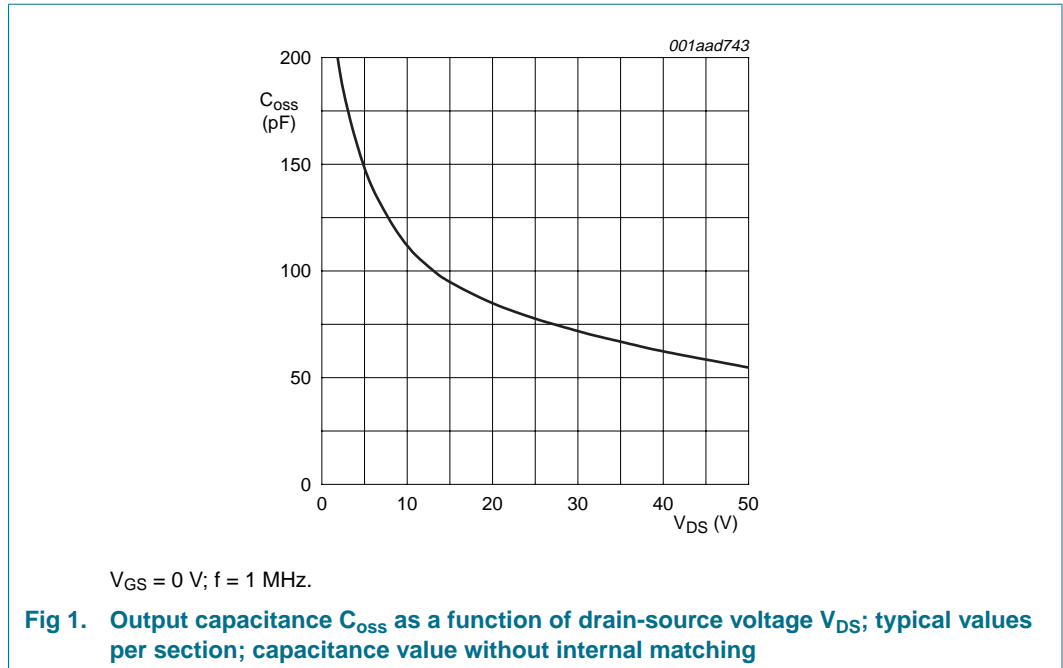
**Table 6: Characteristics**

$T_j = 25\text{ }^{\circ}\text{C}$  unless otherwise specified.

Symbol	Parameter	Conditions [1]	Min	Typ	Max	Unit
$V_{(BR)DSS}$	drain-source breakdown voltage	$V_{GS} = 0\text{ V}; I_D = 5\text{ mA}$	65	-	-	V
$V_{GSth}$	gate-source threshold voltage	$V_{DS} = 20\text{ V}; I_D = 250\text{ mA}$	5.2	-	6.2	V
$I_{DSS}$	drain leakage current	$V_{GS} = 0\text{ V}; V_{DS} = 32\text{ V}$	-	-	2.2	$\mu\text{A}$
$I_{DSX}$	drain cut-off current	$V_{GS} = V_{GSth} + 6\text{ V}; V_{DS} = 10\text{ V}$	-	41	-	A
$I_{GSS}$	gate leakage current	$V_{GS} = 10\text{ V}; V_{DS} = 0\text{ V}$	-	-	40	nA
$g_{fs}$	forward transconductance	$V_{GS} = 20\text{ V}; I_D = 16\text{ A}$	-	10	-	S
$R_{DSon}$	drain-source on-state resistance	$V_{GS} = V_{GSth} + 6\text{ V}; I_D = 9\text{ A}$	-	80	-	m $\Omega$
$C_{iss}$	input capacitance	$V_{GS} = 0\text{ V}; V_{DS} = 32\text{ V}; f = 1\text{ MHz}$	[2] -	200	-	pF
$C_{oss}$	output capacitance	$V_{GS} = 0\text{ V}; V_{DS} = 32\text{ V}; f = 1\text{ MHz}$	[2] -	70	-	pF
$C_{rss}$	reverse transfer capacitance	$V_{GS} = 0\text{ V}; V_{DS} = 32\text{ V}; f = 1\text{ MHz}$	[2] -	2.5	-	pF

[1]  $I_D$  is the drain current.

[2] Capacitance values without internal matching.



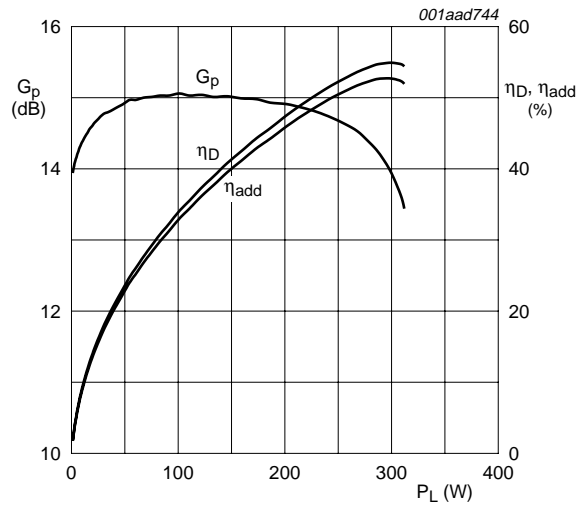
## 7. Application information

**Table 7: RF performance in a common-source 860 MHz narrowband test circuit**

$T_h = 25^\circ\text{C}$  unless otherwise specified. [1]

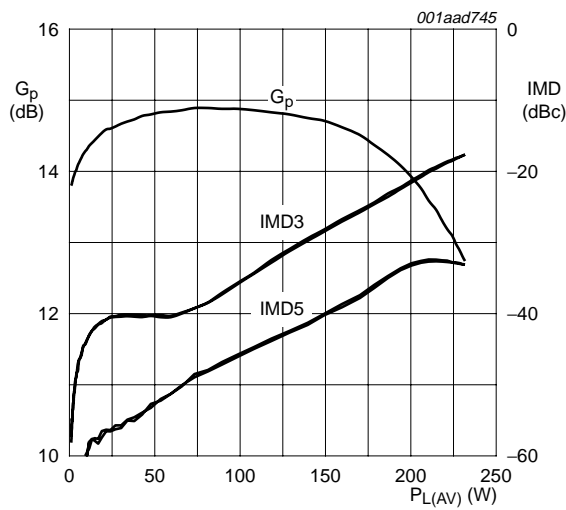
Mode of operation	f (MHz)	$V_{DS}$ (V)	$I_{Dq}$ (A)	$P_{L(PEP)}$ (W)	$P_{L(AV)}$ (W)	$G_p$ (dB)	$\eta_D$ (%)	IMD3 (dBc)	$\Delta G_p$ (dB)
2-tone, class AB	$f_1 = 860;$ $f_2 = 860.1$	32	$2 \times 0.9$	300	-	> 14	> 40	$\leq -25$	$\leq 1$
DVB-T (8K OFDM)	858	32	$2 \times 0.9$	-	70	> 14	> 26	$\leq -25$	-

[1] Sync. compression: input sync.  $\geq 33\%$ , output sync. 27%.



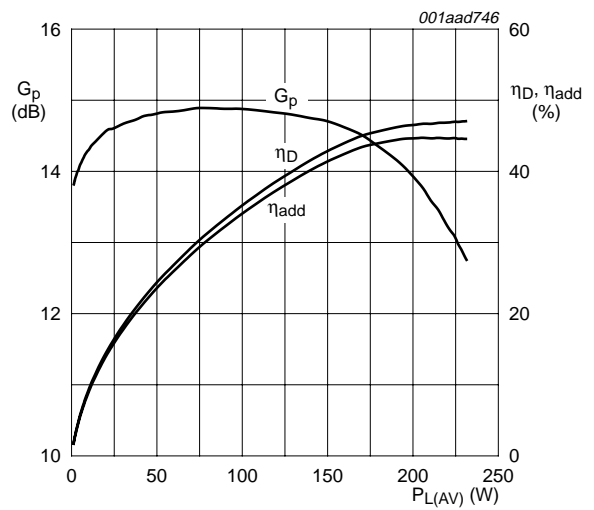
$V_{DS} = 32\text{ V}$ ;  $f = 860\text{ MHz}$ ;  $I_{Dq} = 2 \times 0.9\text{ A}$ ;  $T_h = 25\text{ }^\circ\text{C}$ .

**Fig 2. CW power gain  $G_p$ , drain efficiency  $\eta_D$  and power added efficiency  $\eta_{add}$  as a function of output power  $P_L$ ; typical values**



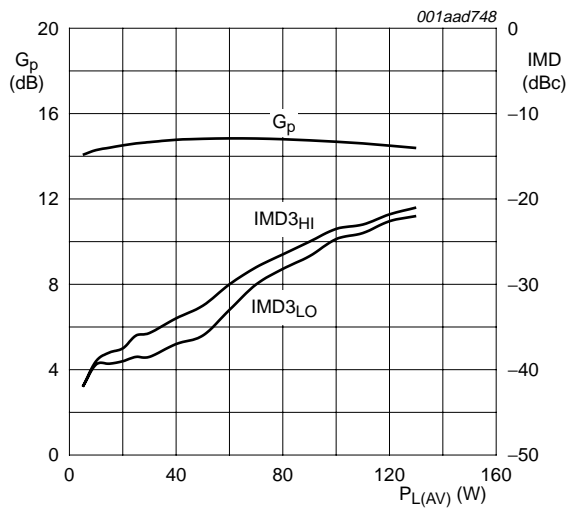
$V_{DS} = 32\text{ V}$ ;  $f_1 = 860\text{ MHz}$ ;  $f_2 = 860.1\text{ MHz}$ ;  
 $I_{Dq} = 2 \times 0.9\text{ A}$ ;  $T_h = 25\text{ }^\circ\text{C}$ .

**Fig 3. 2-tone power gain  $G_p$  and intermodulation distortion IMD as a function of average output power  $P_{L(AV)}$ ; typical values**



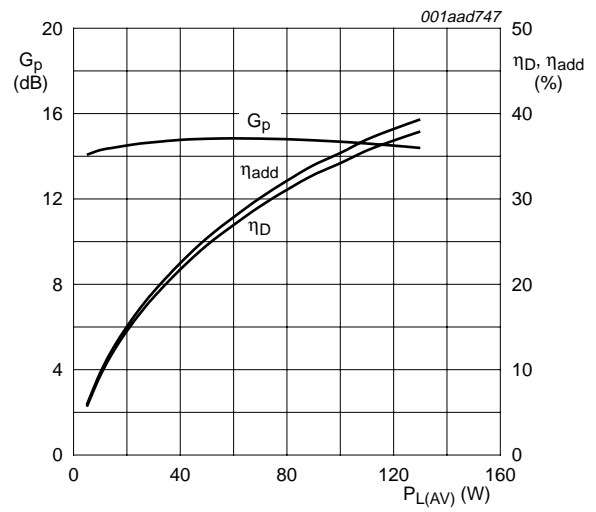
$V_{DS} = 32\text{ V}$ ;  $f_1 = 860\text{ MHz}$ ;  $f_2 = 860.1\text{ MHz}$ ;  
 $I_{Dq} = 2 \times 0.9\text{ A}$ ;  $T_h = 25\text{ }^\circ\text{C}$ .

**Fig 4. 2-tone power gain  $G_p$ , drain efficiency  $\eta_D$  and power added efficiency  $\eta_{add}$  as a function of average output power  $P_{L(AV)}$ ; typical values**



IMD at  $\pm 4.3$  MHz from frequency center.

**Fig 5. DVB-T (8K OFDM) power gain  $G_p$  and third order intermodulation distortion (high-frequency component  $IMD_{3HI}$  and low-frequency component  $IMD_{3LO}$ ) as a function of average output power  $P_{L(AV)}$ ; typical values**

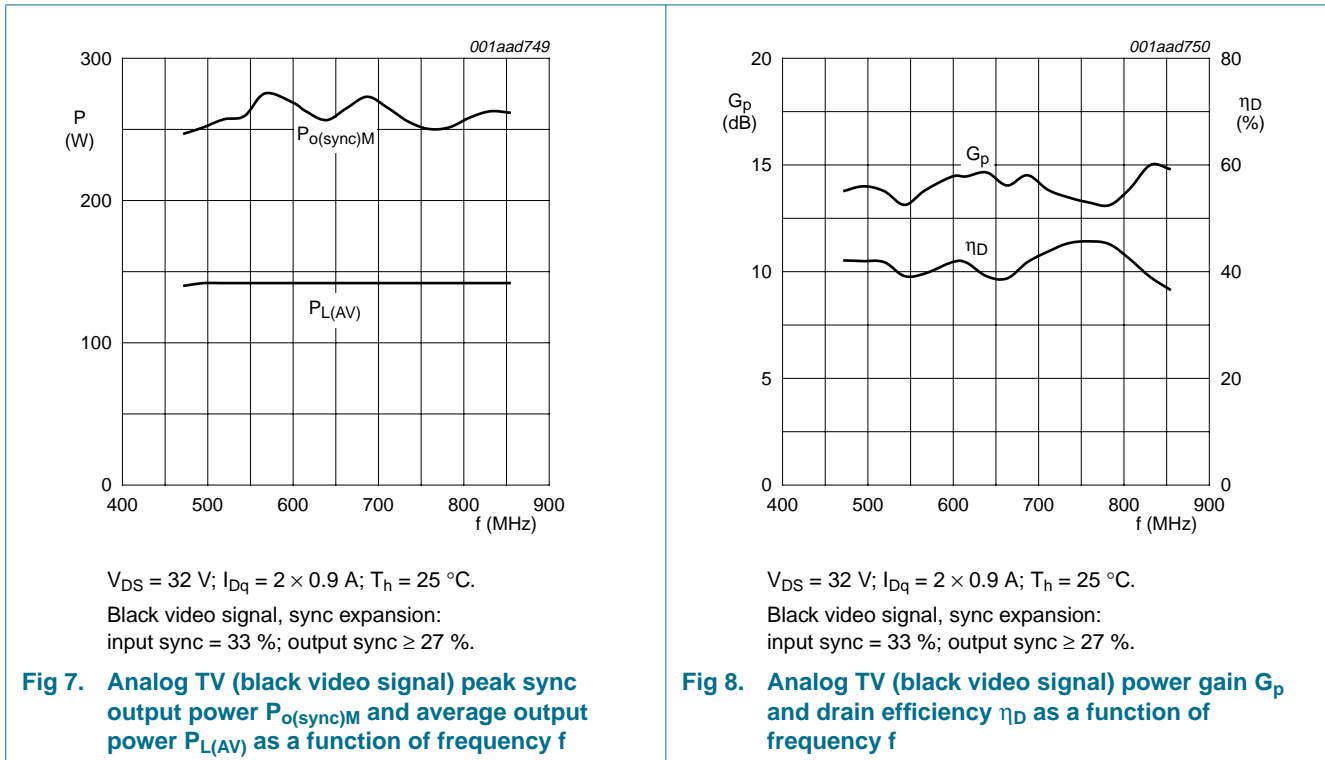


$V_{DS} = 32$  V;  $f = 858$  MHz;  $I_{Dq} = 2 \times 0.9$  A;  $T_h = 25$  °C.

**Fig 6. DVB-T (8K OFDM) power gain  $G_p$ , drain efficiency  $\eta_D$  and power added efficiency  $\eta_{add}$  as a function of average output power  $P_{L(AV)}$ ; typical values**

**7.1 Broadband operation data**

Measured in a common-source broadband (470 MHz to 860 MHz) test circuit.

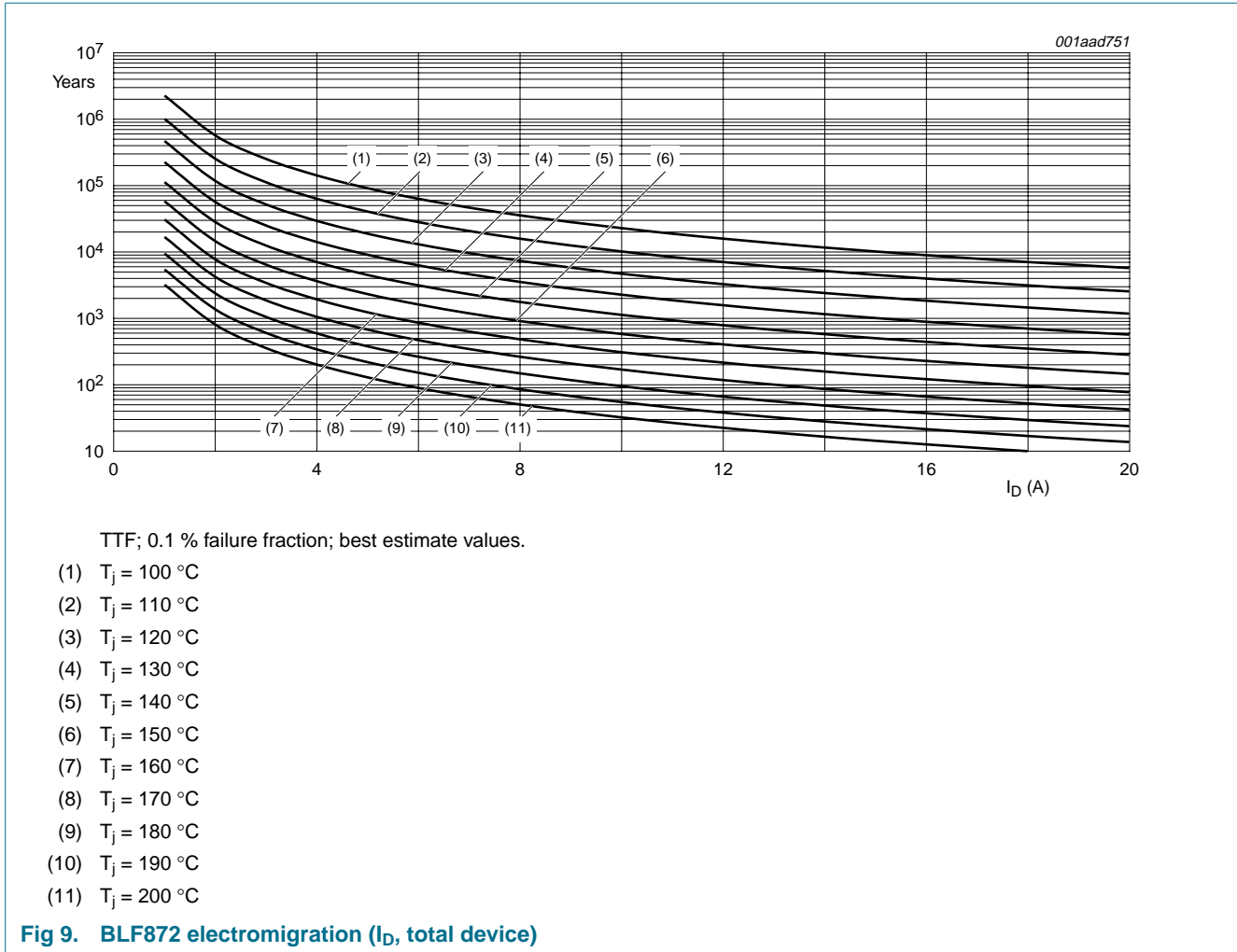


**7.2 Ruggedness in class-AB operation**

The BLF872 is capable of withstanding a load mismatch corresponding to  $V_{SWR} = 10 : 1$  through all phases under the following conditions:  $V_{DS} = 32\text{ V}; f = 860\text{ MHz}$  at rated power.

Measured in a common-source broadband (470 MHz to 860 MHz) test circuit.

7.3 Reliability



8. Test information

Table 8: List of components

For test circuit, see Figure 10, 11 and 12.

Component	Description	Value	Remarks
B1, B2 balun	semi rigid coax	25 $\Omega$	EZ90-25-TP
C1	multilayer ceramic chip capacitor	12 pF	[1]
C2	multilayer ceramic chip capacitor	10 pF	[1]
C3, C5	multilayer ceramic chip capacitor	5.6 pF	[1]
C4	multilayer ceramic chip capacitor	6.8 pF	[1]
C6, C7	multilayer ceramic chip capacitor	2.0 pF	[2]
C8	multilayer ceramic chip capacitor	18 pF	[1]
C9, C10	multilayer ceramic chip capacitor	0.5 pF	[2]
C11, C12	multilayer ceramic chip capacitor	100 pF	[1]
C13, C14	multilayer ceramic chip capacitor	100 pF	[2]

**Table 8:** List of components ...continued  
For test circuit, see [Figure 10](#), [11](#) and [12](#).

Component	Description	Value	Remarks
C15, C16	ceramic capacitor	15 nF	
C17, C18	electrolytic capacitor	470 $\mu$ F	
C20	multilayer ceramic chip capacitor	13 pF	[3]
C21	tekelec trimmer	0.6 pF to 4.5 pF	
C22	multilayer ceramic chip capacitor	3.9 pF	[3]
C23	multilayer ceramic chip capacitor	10 pF	[3]
C24, C32	multilayer ceramic chip capacitor	3.0 pF	[3]
C25	multilayer ceramic chip capacitor	30 pF	[3]
C26, C27	multilayer ceramic chip capacitor	100 pF	[3]
C28, C29	ceramic capacitor	15 nF	
C30, C31	electrolytic capacitor	10 $\mu$ F	
L1	stripline		[4] (W $\times$ L) 24 mm $\times$ 13.1 mm
L2	stripline		[4] (W $\times$ L) 10 mm $\times$ 17.7 mm
L3	stripline		[4] (W $\times$ L) 5 mm $\times$ 16.5 mm
L4	stripline		[4] (W $\times$ L) 2.4 mm $\times$ 15 mm
L5	stripline		[4] (W $\times$ L) 3.5 mm $\times$ 43 mm
L6	stripline		[4] (W $\times$ L) 2 mm $\times$ 43.3 mm
L10	stripline		[4] (W $\times$ L) 24 mm $\times$ 10 mm
L11	stripline		[4] (W $\times$ L) 10 mm $\times$ 15 mm
L12	stripline		[4] (W $\times$ L) 3 mm $\times$ 31.5 mm
L13	stripline		[4] (W $\times$ L) 2 mm $\times$ 43.3 mm
R1	resistor	5.6 $\Omega$	
R2	resistor	5.6 $\Omega$	
R3	resistor	100 $\Omega$	
R4	resistor	100 $\Omega$	
R5	potentiometer	2 k $\Omega$	
R6	potentiometer	2 k $\Omega$	

[1] American technical ceramics type 180R or capacitor of same quality.

[2] American technical ceramics type 100B or capacitor of same quality.

[3] American technical ceramics type 100A or capacitor of same quality.

[4] PCB: Rogers 5880;  $\epsilon_r = 2.2$  F/m; height = 0.79 mm; Cu (top/bottom metallization); thickness copper plating = 35  $\mu$ m.

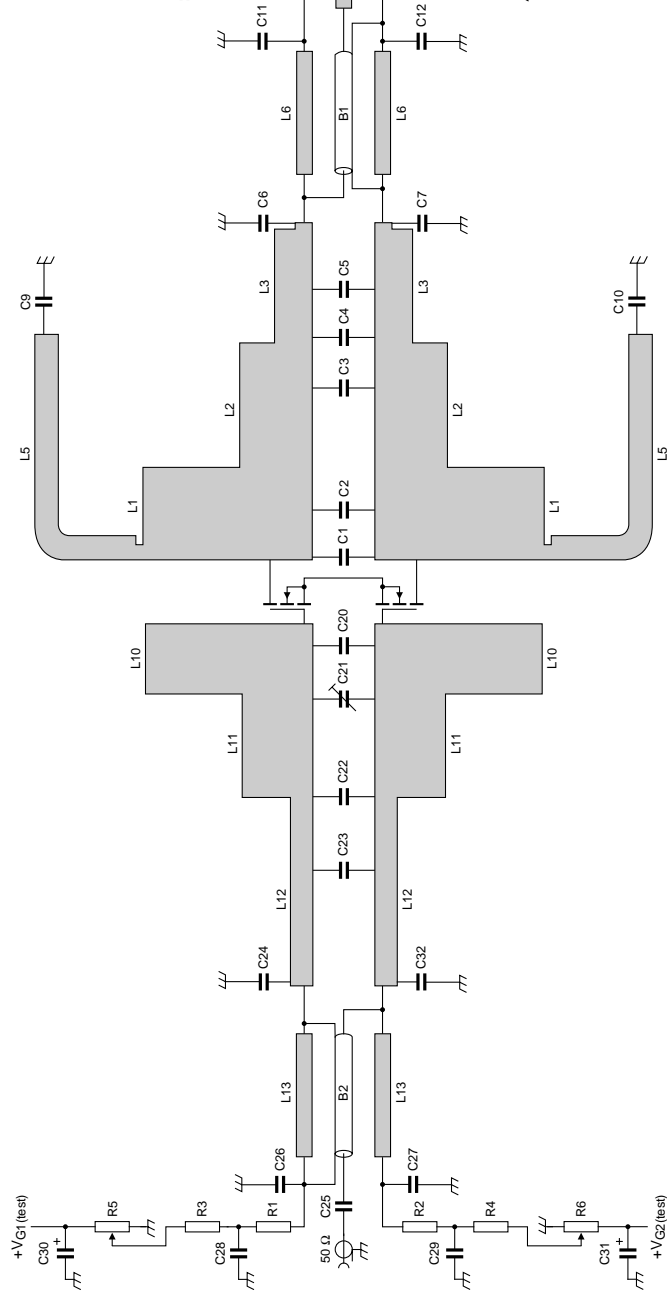
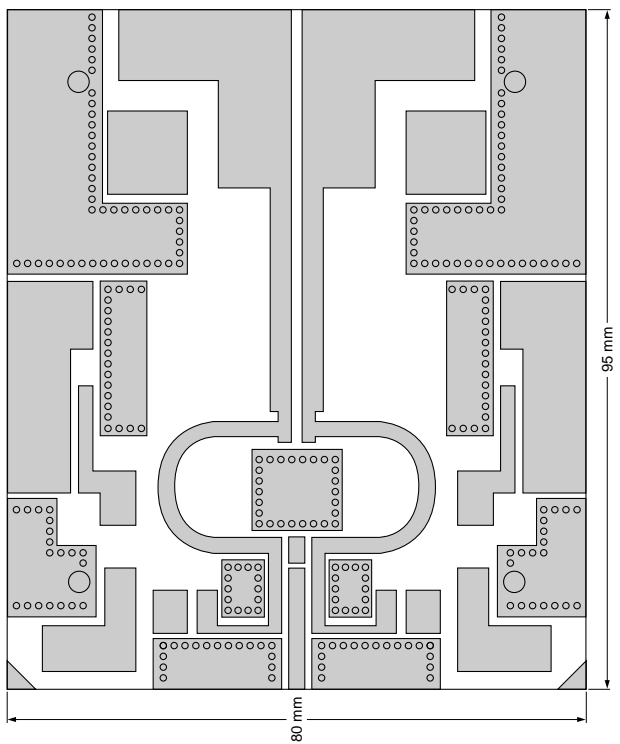
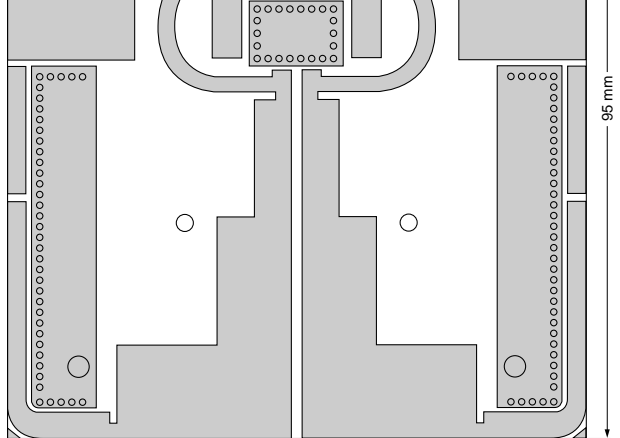


Fig 10. Class-AB common-source broadband test circuit;  $V_{D1(test)}$ ,  $V_{D2(test)}$ ,  $V_{G1(test)}$  and  $V_{G2(test)}$  are drain and gate test voltages



**Fig 11. Printed-circuit board for class-AB broadband test circuit**

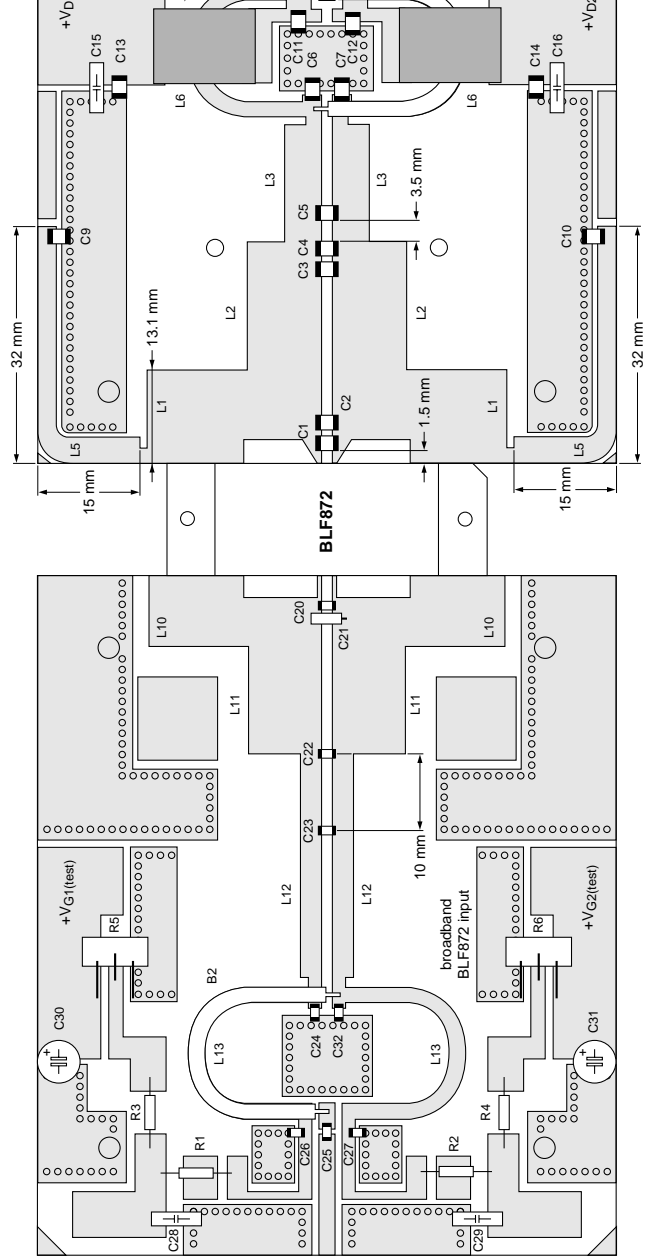


Fig 12. Component layout for class-AB broadband test circuit

9. Package outline

Flanged LDMOST ceramic package; 2 mounting holes; 4 leads

SOT800-1

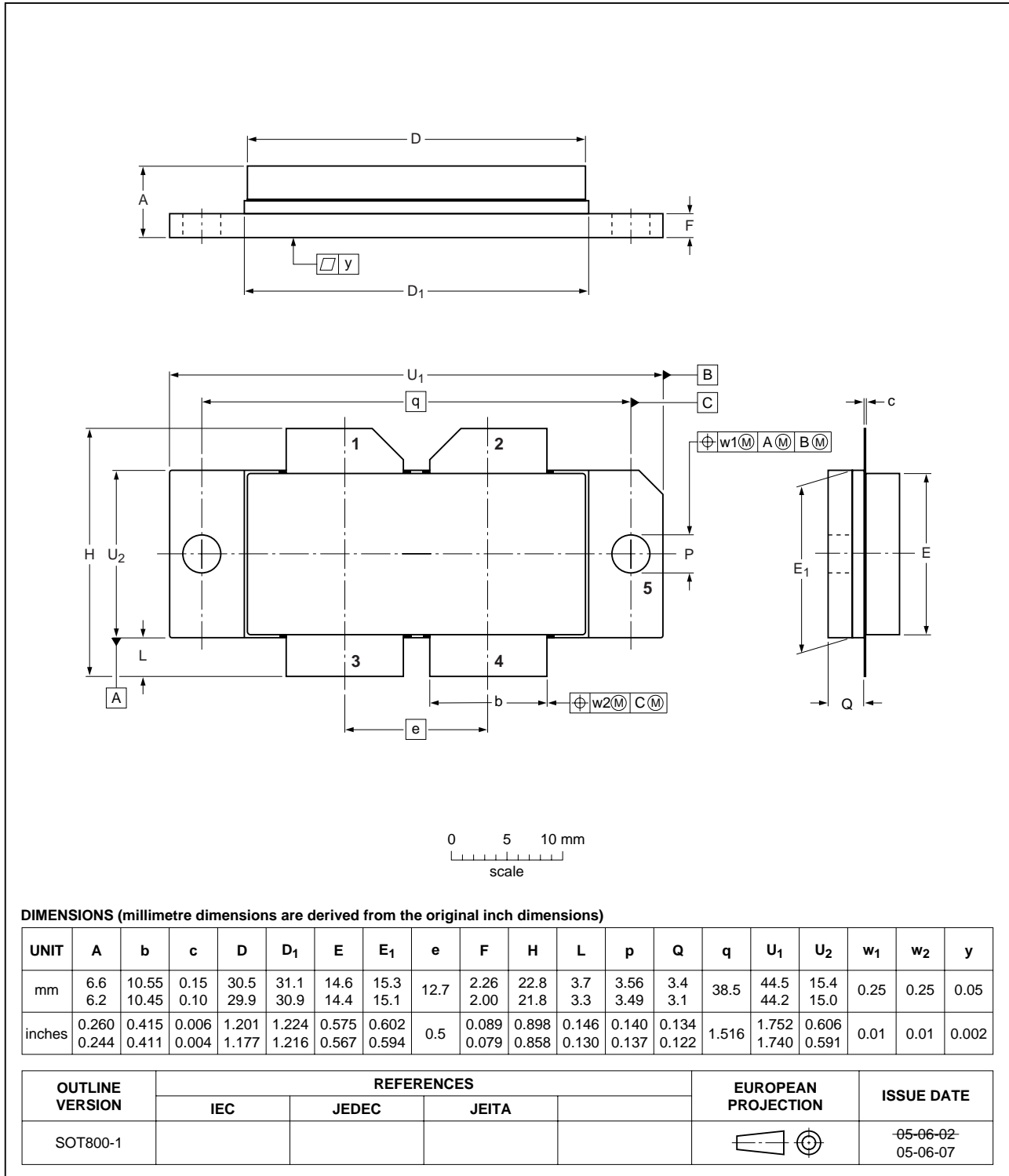


Fig 13. Package outline SOT800-1

## 10. Abbreviations

**Table 9: Abbreviations**

Acronym	Description
CDMA	Code Division Multiple Access
CW	Continuous Wave
DVB	Digital Video Broadcast
EDGE	Enhanced Data rates for GSM Evolution
ESR	Equivalent Series Resistance
EVM	Error Vector Magnitude
GSM	Global System for Mobile communications
IMD	InterModulation Distortion
LDMOS	Laterally Diffused Metal Oxide Semiconductor
OFDM	Orthogonal Frequency Division Multiplexing
PCB	Printed-Circuit Board
PEP	Peak Envelope Power
RF	Radio Frequency
SMD	Surface Mount Device
TTF	Time To Failure
VSWR	Voltage Standing Wave Ratio

## 11. Revision history

**Table 10: Revision history**

Document ID	Release date	Data sheet status	Change notice	Doc. number	Supersedes
BLF872_1	20060220	Product data sheet	-	-	-

## 12. Data sheet status

Level	Data sheet status <sup>[1]</sup>	Product status <sup>[2] [3]</sup>	Definition
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